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| 1. Record Nr.           | UNICAMPANIASUN0131973  |
| Autore                  | Gupta, Sajal   |
| Titolo                  | Endometriosis : A Comprehensive Update / Sajal Gupta, Avi Harlev, Ashok Agarwal  |
| Pubbl/distr/stampa      | ix, 115 p. ; 24 cm   |
| ISBN                    | 8-3-319-18307-7  |
| Edizione                | [Cham : Springer, 2015]  |
| Descrizione fisica      | Pubblicazione in formato elettronico   |
| Altri autori (Persone)  | Agarwal, Ashok   |
| Lingua di pubblicazione | Inglese  |
| Formato                 | Materiale a stampa   |
| Livello bibliografico   | Monografia   |
| 2. Record Nr.           | UNINA9910465399903321  |
| Autore                  | Leroy Claude   |
| Titolo                  | Silicon solid state devices and radiation detection [[electronic resource]] / Claude Leroy, Pier-Giorgio Rancoita                              |
| Pubbl/distr/stampa      | Singapore ; Hackensack, N. J., : World Scientific Publishing Co. Pte Ltd, c2012  |
| ISBN                    | 1-299-28104-4<br>981-4390-05-4   |
| Descrizione fisica      | 1 online resource (430 p.)   |
| Altri autori (Persone)  | RancoitaPier-Giorgio   |
| Disciplina              | 539.20287  |
| Soggetti                | Semiconductor nuclear counters - Design and construction<br>Semiconductor nuclear counters - Materials<br>Silicon carbide<br>Electronic books. |
| Lingua di pubblicazione | Inglese  |
| Formato                 | Materiale a stampa   |
| Livello bibliografico   | Monografia   |
| Note generali           | Description based upon print version of record.  |
| Nota di bibliografia    | Includes bibliographical reference (p. 373-400) and index.   |

## Nota di contenuto

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1.2 Collision and Radiation Energy-Losses of Electrons and Positrons  
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## Sommario/riassunto

This book addresses the fundamental principles of interaction between radiation and matter, the principles of working and the operation of particle detectors based on silicon solid state devices. It covers a broad scope in the fields of application of radiation detectors based on silicon solid state devices from low to high energy physics experiments, including in outer space and in the medical environment. This book also covers state-of-the-art detection techniques in the use of radiation detectors based on silicon solid state devices and their readout electronics, including the latest develo